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| Notice of References Cited | Application/Control No. 10/075,265 | Applicant(s)/Patent Under Reexamination LIAO, YI MING | |
| | Examiner Michael J. Yigdall | Art Unit 2122 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-2002/0069102 | 06-2002 | Vellante et al. | 705/10 |
| | B | US-5,499,340 | 03-1996 | Barritz, Robert | 714/47 |
| | C | US-5,881,225 | 03-1999 | Worth, Erik K. | 713/200 |
| | D | US-6,086,618 | 07-2000 | Al-Hilali et al. | 703/2 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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